Surface Mount - 400V - 800V







## Additional Information







Accessories



Samples

### **Description**

The MAC12x is designed for high performance full—wave AC control applications where high noise immunity and commutating di/dt are required.

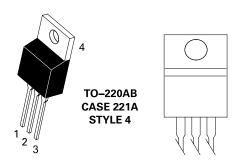
#### **Features**

- Blocking Voltage to 800 Volts
- On-State Current Rating of 12 Amperes RMS at 70°C
- Uniform Gate Trigger Currents in Three Quadrants, Q1, Q2, and Q3
- High Immunity to dv/dt 250 V/µs Minimum at 125°C
- High Commutating di/dt 6.5 A/ms Minimum at 125°C
- Industry Standard TO-220 Package
- High Surge Current Capability100 Amperes
- These Devices are Pb-Free and are RoHS Compliant

#### **Functional Diagram**



#### **Pin Out**



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### Maximum Ratings (TJ = 25°C unless otherwise noted)

| Rating   | Symbol               | Value                                  | Unit              |       |
|--|----------------------|--|-------------------|-------|
| Peak Repetitive Off-State Voltage (Note 1) (Gate Open, Sine Wave 50 to 60 Hz, T <sub>J</sub> = 40° to 125°C)  MAC12D MAC12D MAC12N |                      | V <sub>DRM</sub> ,<br>V <sub>RRM</sub> | 400<br>600<br>800 | V     |
| On-State RMS Current (Full Cycle Sine Wave, 60 Hz, $T_c = 7$   | I <sub>T (RMS)</sub> | 12                                     | А                 |       |
| Peak Non-Repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, T,= 125°C)   |                      | I <sub>TSM</sub>                       | 100               | А     |
| Circuit Fusing Consideration (t = 8.3 ms)  |                      | l²t                                    | 41                | A²sec |
| Peak Gate Power (Pulse Width $\leq$ 1.0 $\mu$ s, $T_{c}$ = 80°C)   | P <sub>GM</sub>      | 16                                     | W                 |       |
| Average Gate Power (t = $8.3 \text{ ms}$ , $T_{c} = 80^{\circ}\text{C}$ )  |                      | P <sub>G(AV)</sub>                     | 0.35              | W     |
| Operating Junction Temperature Range   |                      | $T_{J}$                                | -40 to +125       | °C    |
| Storage Temperature Range  | T <sub>stg</sub>     | -40 to +150                            | °C                |       |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the

#### **Thermal Characteristics**

| Rating   |   | Symbol                               | Value       | Unit |
|--|---|--------------------------------------|-------------|------|
| Thermal Resistance,  | Junction-to-Case (AC) Junction-to-Ambient | R <sub>ejc</sub><br>R <sub>eja</sub> | 2.2<br>62.5 | °C/W |
| Maximum Lead Temperature for Soldering Purpose: 10 seconds | s, 1/8" from case for                     | T <sub>L</sub>                       | 260         | °C   |

### **Electrical Characteristics - OFF** (TJ = 25°C unless otherwise noted; Electricals apply in both directions)

| Characteristic                          |                        | Symbol             | Min | Тур | Max  | Unit |
|---|------------------------|--------------------|-----|-----|------|------|
| Peak Repetitive Blocking Current        | T <sub>1</sub> = 25°C  | I <sub>DRM</sub> , | -   | -   | 0.01 | m Λ  |
| $(V_D = V_{DRM} = V_{RRM}$ ; Gate Open) | T <sub>J</sub> = 125°C | IRRM               | -   | -   | 2.0  | mA   |

### Electrical Characteristics - ON (TJ = 25°C unless otherwise noted; Electricals apply in both directions)

| Characteristic  |              | Symbol          | Min | Тур  | Max  | Unit |
|---|--------------|-----------------|-----|------|------|------|
| Peak On–State Voltage (Note 2) ( $I_{TM} = \pm 11 \text{ A}$ )                                  |              | $V_{TM}$        | -   | -    | 1.85 | V    |
| Gate Trigger Current  | MT2(+), G(+) |                 | 5.0 | 13   | 35   | mA   |
| (Continuous dc)   | MT2(+), G(-) | l <sub>gt</sub> | 5.0 | 13   | 35   |      |
| $(V_{D} = 12 \text{ V}, R_{L} = 100 \Omega)$  | MT2(-), G(-) |                 | 5.0 | 13   | 35   |      |
| Holding Current ( $V_p = 12 \text{ V}$ , Gate Open, Initiating Current = $\pm 150 \text{ mA}$ ) |              | I <sub>H</sub>  | -   | 20   | 40   | mA   |
|   | MT2(+), G(+) | IL              | _   | 20   | 50   | mA   |
| Latching Current $(V_D = 24 \text{ V}, I_G = 35 \text{ mA})$                                    | MT2(+), G(-) |                 | _   | 30   | 80   |      |
| (V <sub>D</sub> = 24 V, I <sub>G</sub> = 33 III/)   | MT2(-), G(-) |                 | _   | 20   | 50   |      |
|   | MT2(+), G(+) |                 | 0.5 | 0.78 | 1.5  |      |
| Gate Trigger Voltage $(V_D = 12 \text{ V}, R_I = 100 \Omega)$                                   | MT2(+), G(-) | $V_{GT}$        | 0.5 | 0.70 | 1.5  | V    |
| (v <sub>D</sub> = 12 v, 11 <sub>L</sub> = 100 12)   | MT2(-), G(-) |                 | 0.5 | 0.71 | 1.5  |      |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different

<sup>2.</sup> Indicates Pulse Test: Pulse Width  $\leq$  2.0 ms, Duty Cycle  $\leq$  2%



Recommended Operating Conditions may affect device reliability.

1. V<sub>DBM</sub> and V<sub>BBM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

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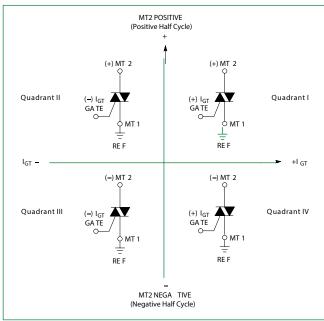
### **Dynamic Characteristics**

| Characteristic   | Symbol               | Min | Тур | Max | Unit |
|--|----------------------|-----|-----|-----|------|
| Rate of Change of Commutating Current See Figure 10. ( $V_D = 400  \text{V}$ , $I_{TM} = 4.4  \text{A}$ , Commutating dv/dt = 18 V/µs,Gate Open, $T_J = 125  ^{\circ}\text{C}$ , f = 250 Hz, No Snubber) | di/dt <sub>(C)</sub> | 6.5 | -   | -   | A/ms |
| Critical Rate of Rise of Off-State Voltage $(V_D = Rated V_{DRM}, Exponential Waveform, Gate open, T_J = 125°C)$   | dV/dt                | 250 | 500 | _   | V/µs |
| Repetitive Critical Rate of Rise of On-State Current IPK = 50 A; PW = 40 µsec; diG/dt = 200 mA/µsec; f = 60 Hz   | di/dt                | _   | -   | 10  | A/µs |

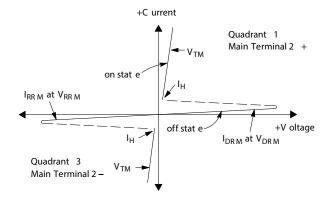
### **Voltage Current Characteristic of SCR**

| Symbol                | Parameter                                 |
|-----------------------|---|
| $V_{DRM}$             | Peak Repetitive Forward Off State Voltage |
| I <sub>DRM</sub>      | Peak Forward Blocking Current             |
| $V_{_{\mathrm{RRM}}}$ | Peak Repetitive Reverse Off State Voltage |
| I <sub>RRM</sub>      | Peak Reverse Blocking Current             |
| $V_{TM}$              | Maximum On State Voltage                  |
| l <sub>u</sub>        | Holding Current                           |

#### **Quadrant Definitions for a Triac**



All polarities are referenced to MT1.
With in –phase signals (using standard AC lines) quadrants I and III are used



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Figure 1. Typical Gate Trigger Current vs Junction Temperature

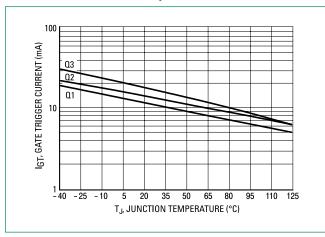
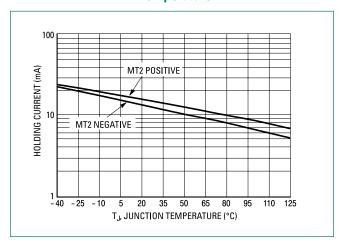


Figure 3. Typical Holding Current vs Junction Temperature



**Figure 5. Typical RMS Current Derating** 

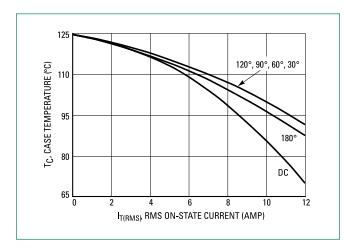


Figure 2. Typical Gate Trigger Voltage vs Junction Temperature

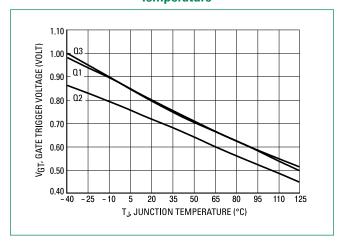


Figure 4. Typical Latching Current vs Junction Temperature

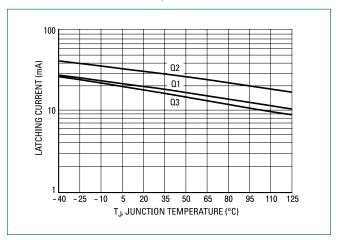
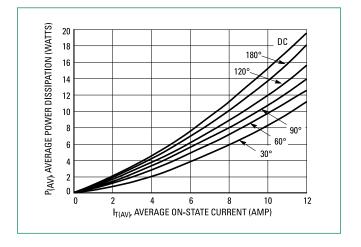


Figure 6. On-State Power Dissipation





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**Figure 7. Typical On-State Characteristics** 

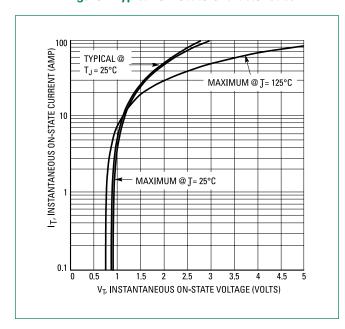
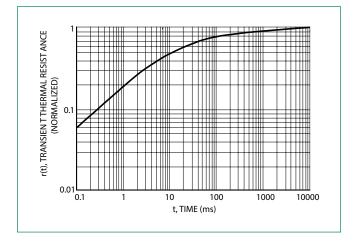


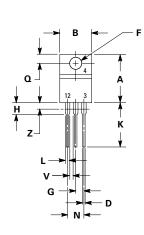
Figure 8. Typical Thermal Response

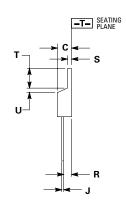




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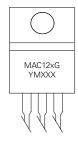
#### **Dimensions**





### **Part Marking System**





=Year M = Month XXX = Lot Serial Code G = Pb-Free Package

Pin Assignment

Main Terminal 1

Main Terminal 2

Main Terminal 2

| Dim | Inches |       | Millimeters |       |  |
|-----|--------|-------|-------------|-------|--|
| Dim | Min    | Max   | Min         | Max   |  |
| Α   | 0.590  | 0.620 | 14.99       | 15.75 |  |
| В   | 0.380  | 0.420 | 9.65        | 10.67 |  |
| С   | 0.178  | 0.188 | 4.52        | 4.78  |  |
| D   | 0.025  | 0.035 | 0.64        | 0.89  |  |
| F   | 0.142  | 0.147 | 3.61        | 3.73  |  |
| G   | 0.095  | 0.105 | 2.41        | 2.67  |  |
| Н   | 0.110  | 0.130 | 2.79        | 3.30  |  |
| J   | 0.018  | 0.024 | 0.46        | 0.61  |  |
| K   | 0.540  | 0.575 | 13.72       | 14.61 |  |
| L   | 0.060  | 0.075 | 1.52        | 1.91  |  |
| N   | 0.195  | 0.205 | 4.95        | 5.21  |  |
| Q   | 0.105  | 0.115 | 2.67        | 2.92  |  |
| R   | 0.085  | 0.095 | 2.16        | 2.41  |  |
| S   | 0.045  | 0.060 | 1.14        | 1.52  |  |
| Т   | 0.235  | 0.255 | 5.97        | 6.47  |  |
| U   | 0.000  | 0.050 | 0.00        | 1.27  |  |
| V   | 0.045  |       | 1.15        |       |  |
| Z   |        | 0.080 |             | 2.04  |  |

| Ordering Informa | tion |
|------------------|------|
| Device           | F    |
| MAC12DG          | _    |
| MAC12MG          | T(   |
| MAC12NG          | (1   |
|                  |      |

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3 4

| Device  | Package    | Shipping         |
|---------|------------|------------------|
| MAC12DG | TO 000 4 D |                  |
| MAC12MG | TO-220AB   | 1000 Units / Box |

- 1. Dimensioning and tolerancing per ansi y14.5m, 1982.
- 3. Dimension z defines a zone where all body and lead irregularities are allowed.

